Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination GRUMBINE ET AL.	
10/691,254		
Examiner	Art Unit	
Kin-Chan Chen	1765	

SEARCHED					
Class	Subclass	Date	Examiner		
438	689	10/21/2005	ксс		
438	692				
25-2	79.1				
25-2	79.5				
216	89	10/21/05	KCC		
			,		
		*			

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	****		•		
	.				

(INCLUDING SEARCH	SIKAIEGY)
	DATE	EXMR
East Keyword scarce USPAT, USPG-pub. Epo, Jpo, Derwent ZBM-TDB, Inventor scarce	10/21/2005	ксс
	·	
		`
	-	
		_